



Ultralow Noise Precision Op Amp

ANALOG DEVICES INC

65E D

AD OP-07

1.1 Scope.

This specification covers the detail requirements for a linear bipolar monolithic low drift amplifier.

1.2 Part Number.

The complete part number per Table 1 of this specification is as follows:

| Device | Part Number |
|--------|-------------------|
| -1 | AD OP-07(X)/883B |
| -2 | AD OP-07A(X)/883B |

1.2.3 Case Outline.

See Appendix 1 of General Specification ADI-M-1000: package outline:

| (X) | Package | Description |
|-----|---------|-----------------------|
| Q | Q-8 | 8-Pin Cerdip |
| H | H-08A | 8-Pin TO-99 Metal Can |

1.3 Absolute Maximum Ratings. (T_A = +25°C unless otherwise noted)

| | |
|--|-----------------|
| Supply Voltage | ±22V |
| Internal Power Dissipation ¹ | 500mW |
| Differential Input Voltage | ±V _S |
| Input Voltage | ±V _S |
| Output Short Circuit Duration | Indefinite |
| Storage Temperature Range | -65°C to +150°C |
| Operating Temperature Range | |
| AD OP-07A, AD OP-07 | -55°C to +125°C |
| Lead Temperature Range (Soldering 60sec) | 300°C |

NOTE

¹Maximum package power dissipation vs. ambient temperature.

| Package Type | MAXIMUM AMBIENT | DERATE ABOVE MAXIMUM |
|--------------|------------------------|----------------------|
| | Temperature for Rating | Ambient Temperature |
| TO-99 (H) | 80°C | 7.1mW/°C |
| Cerdip (Q) | 75°C | 6.7mW/°C |

1.5 Thermal Characteristics.

Thermal Resistance θ_{JC} = 65°C/W for H-08A
 θ_{JA} = 150°C/W for H-08A
 θ_{JC} = 22°C/W for Q-8
 θ_{JA} = 110°C/W for Q-8

AD OP-07 — SPECIFICATIONS

0816800 0041075 4T2 ANA

Table 1.

| Test | Symbol | Device | Sub Group 1 | Sub Group 2, 3 | Sub Group 4 | Test Condition ¹ | Units |
|------------------------------|----------------------|--------|-------------|----------------|-------------|--|-------------|
| Gain Open Loop | A _{VS} | -1 | 2000 | 1500 | | R _L ≥ 2kΩ, V _{OUT} = ± 10V | V/mV min |
| | | -2 | 3000 | 2000 | | R _L ≥ 2kΩ, V _{OUT} = ± 10V | |
| Output Voltage Swing | V _{OP} | -1, 2 | 12.5 | | | R _L ≥ 10kΩ | ± V min |
| | | | 12.0 | 12 | | R _L = 2kΩ | |
| | | | 10.5 | | | R _L = 1kΩ | |
| Input Offset Voltage | V _{IO} | -1 | 75 | 200 | | | ± μV max |
| | | -2 | | 60 | 25 | | |
| Input Offset Drift | ΔV _{IO} /ΔT | -1 | | 1.3 | | | ± μV/°C max |
| | | -2 | | 0.6 | | | |
| Input Offset Current | I _{IO} | -1 | 2.8 | 5.6 | | | ± nA max |
| | | -2 | 2.0 | 4.0 | | | |
| Input Bias Current | I _{IB} | -1 | 3 | 6 | | | ± nA max |
| | | -2 | 2 | 4 | | | |
| Common-Mode Rejection Ratio | CMRR | -1, 2 | 110 | 106 | | V _{CM} = ± CMVR | dB min |
| Common-Mode Voltage Range | CMVR | -1, 2 | 13 | 13 | | | ± V min |
| Power Supply Current | I _Q | -1, 2 | 4 | | | | mA max |
| Power Consumption | P _D | -1, 2 | 120 | | | V _S = ± 15V | mW max |
| Power Supply Rejection Ratio | PSRR | -1, 2 | 100 | 94 | | ± 3V ≤ V _S ≤ ± 18V | dB min |

NOTE
¹V_S = ± 15, unless otherwise noted.

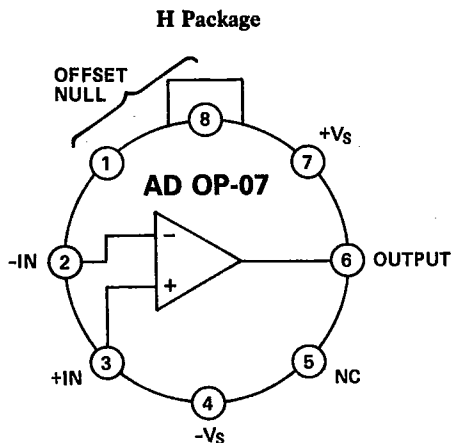
ANALOG DEVICES INC

65E D

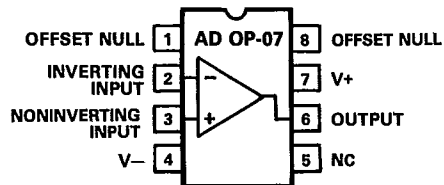
ANALOG DEVICES INC

3.2.1 Functional Block Diagram and Terminal Assignments.

Top View



Q Package (Cerdip)



3.2.4 Microcircuit Technology Group.

This microcircuit is covered by technology group (49).

4.2.1 Life Test/Burn-In Circuit.

Steady state life test is per MIL-STD-883 Method 1005. Burn-in is per MIL-STD-883 Method 1015 test condition (B).

